Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination BAERVELDT, KONRAD | Examiner | Vishal Patel | 3673 | Page 1 of 1 | U.S. PATENT DOCUMENTS * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification | Classification | Control No. | Applicant(s)/Patent Under Reexamination BAERVELDT, KONRAD | Page 1 of 1 | Page 1 of 1 | Classification | Classification | Applicant(s)/Patent Under Reexamination BAERVELDT, KONRAD | Page 1 of 1 | Page 1 of 1 | Classification | Control No. | Applicant(s)/Patent Under Reexamination BAERVELDT, KONRAD | Page 1 of 1 | Classification | Classification | Control No. | Applicant(s)/Patent Under Reexamination BAERVELDT, KONRAD | Page 1 of 1 | Control No. | Cont

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,977,018	12-1990	Irrgeher et al.	428/314.4
*	В	US-5,794,663	08-1998	Kiest et al.	138/98
*	С	US-5,935,695	08-1999	Baerveldt, Konrad	428/218
*	D	US-5,941,815	08-1999	Chang, Stanley F.	600/114
*	E	US-6,021,815	02-2000	Kiest et al.	138/98
	F	US-			
	G	US-			
	н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
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	Ø					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.